

<b>Notice of References Cited</b>	Application/Control No. 10/537,428	Applicant(s)/Patent Under Reexamination NEIL ET AL.	
	Examiner DEBBIE M. LE	Art Unit 2168	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,051,080 B1	05-2006	Paul et al.	709/217
*	B	US-7,191,211 B2	03-2007	Tuli, Raja	709/203
*	C	US-2002/0112078 A1	08-2002	Yach, David	709/246
*	D	US-2005/0014494 A1	01-2005	Owen et al.	455/419
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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